

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination SONG ET AL.	
		Examiner A. Sefer	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,515,727 /	02-2003	Yoon et al	349/143
	B	US-2001/0007487 /	07-2001	Yoon et al	349/106
	C	US-6,084,650 /	07-2000	Sekiguchi	349/106
	D	US-6,466,296 /	10-2002	Yamada et al	349/160
	E	US-6,215,536 /	04-2001	Ebihara et al	349/86
	F	US-2001/0033353 /	10-2001	Shimoshikiyo	349/129
	G	US-69,222,605 /	04-2001	Tillin et al	349/167
	H	US-6,515,727-	02-2003	Yoon et al	
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001-272665	10-2001	Japan		
	O	JP 11-30773	02-1999	Japan		
	P	JP 11-119206	04-1999	Japan	Fijita et al	
	Q	JP 11-352490	12-1999	Japan	Song et al	
	R	JP 8-254716	10-1996	Japan	Minato et al	
	S	JP 10-197860	07-1998	Japan	Ito et al	
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.